


<b>Search Notes</b>  	<b>Application/Control No.</b>  10029394	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  Nguyen, Khiem D	<b>Art Unit</b>  2823

SEARCHED			
Class	Subclass	Date	Examiner
438	151, 197, 201, 257, 261, 288, FOR431	10/25/2007	KN
257	314, 315, E29.129, E29.3, E21.422, E21.68, E21.687, E21.688	10/25/2007	KN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search updated (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	10/25/2007	KN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner